

新普科技股份有限公司
新世電子(常熟)有限公司
新普科技(重慶)有限公司
兆普電子(上海)有限公司

Control Number : SLEU-1311003

UN38.3 Test Report

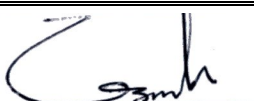
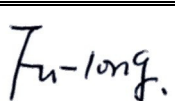
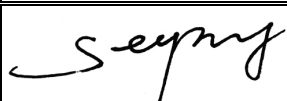
Recommendations on the TRANSPORT OF DANGEROUS GOODS

(Manual of Tests and Criteria, Fifth revised edition)

Customer : Lenovo

Model : L13M4P02

Rating : 7.4V, 7400mAh / 54Wh

Approved By	Checked By	Prepared By
		

SIMPLO TECHNOLOGY CO., LTD.

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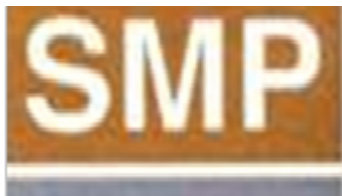
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1. Purpose of the Test :

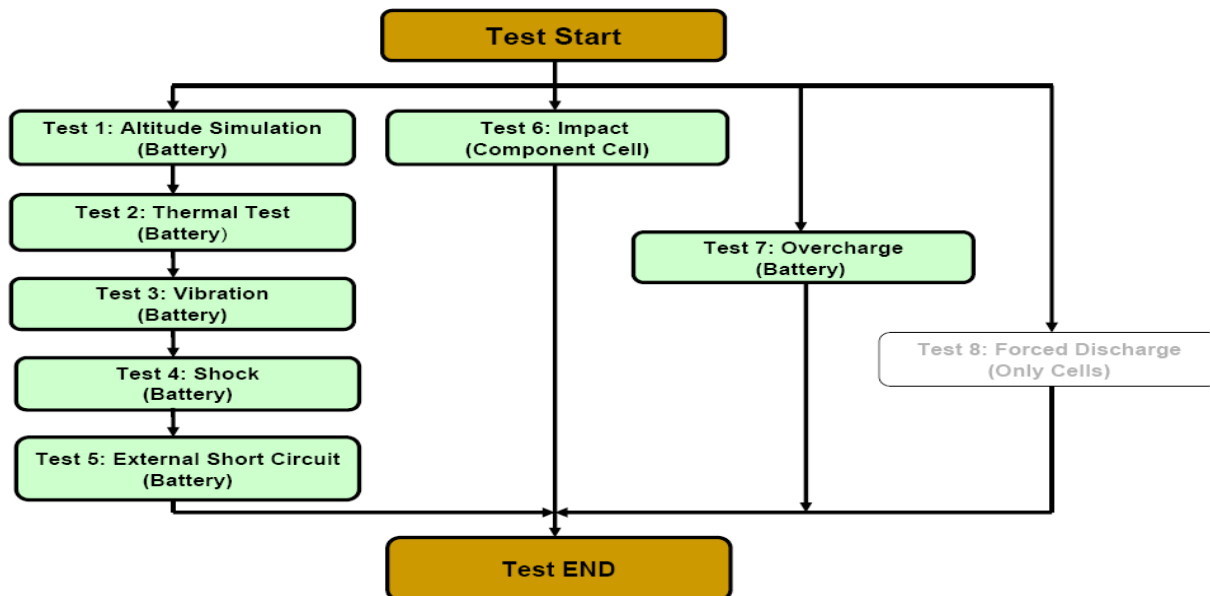
To test each cell/battery is of the type proved to meet the requirements in the Recommendations on the TRANSPORT OF DANGEROUS GOODS, Manual of Tests and Criteria, Fifth revised edition.

2. Test Quantity :

- 2.1 Four batteries, at first cycle, in fully charged states. (for T.1~T.5 test)
- 2.2 Four batteries, after fifty cycles ending in fully charged states. (for T.1~T.5 test)
- 2.3 Ten component cells, at first cycle at 50% of the design rated capacity. (for T.6 test)
- 2.4 Four batteries, at first cycle, in fully charged states. (for T.7 test)
- 2.5 Four batteries, after fifty cycles ending in fully charged states. (for T.7 test)

3. Test Procedure :

- 3.1 All detail related test procedure shall be follow TRANSPORT OF DANGEROUS GOODS, Manual of Tests and Criteria, Fifth revised edition.
- 3.2 Test flow shall be follow below statement.





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4. Test Result :

4.1 T.1 ~T.4 Test results: **Pass**

4.1.1 All batteries could meet the requirement, mass loss less than 0.1% and voltage drop less than 10% after the test.

4.1.2 No leakage, no venting, no disassembly, no rupture and no fire.

4.2 T.5 Test results: **Pass**

4.2.1 All batteries could meet the requirement, external temperature did not exceed 170°C.

4.2.2 All batteries were no disassembly, no rupture and no fire during the test and within six hours after the test.

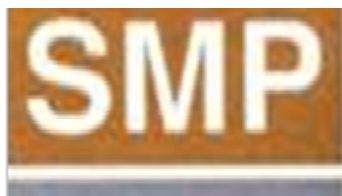
4.3 T.6 Test results: **Pass**

4.3.1 All component cells could meet the requirement, external temperature did not exceed 170°C.

4.3.2 All component cells were no disassembly and no fire during the test and within six hours after the test.

4.4 T.7 Test result: **Pass**

4.4.1 All batteries could meet no disassembly and no fire during the test and within seven days after the test.



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Control Number : SLEU-1311003

5. Test Equipment :

SMP SIMPLO TECHNOLOGY CO., LTD.

Revised date: 2013-11-15

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Date:2013-11-15

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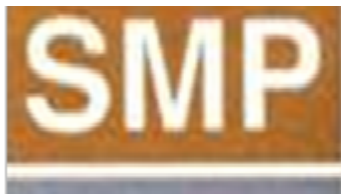
Project No.: SLEU-1311003

Test Instruments Reference List								
Used	Instrument ID	Instrument Name	Type	Range Used	Manufacturer	Calibration Date_Last	Calibration Date_Next	Remarks
	Pretest							
V	ML-761	Learning	715C	0~18V 0~8A	SMP	2013/3/28	2014/3/28	
V	ML-762	Learning	715C	0~18V 0~8A	SMP	2013/3/22	2014/3/22	
V	ML-763	Learning	715C	0~18V 0~8A	SMP	2013/3/22	2014/3/22	
	T.1 Altitude Simulation							
V	ML-522	Altitude		Kpa:30~90	新匠	2013/8/15	2014/8/15	
V	ML-257	Multimeter	HP 34401A	Note 1	Agilent	2013/3/8	2014/3/8	
V	ML-494	Electronic Balance	XS1220M-SCS	1-1000 gf	CHUANHUA	2013/8/15	2014/8/15	
V	ML-550	Data Logger	313	15~35 °C; 30~80 %RH	CENTER	2013/10/16	2014/10/16	
	T.2 Thermal Test							
V	ML-789	Thermal Shock	GTST-080-65-AW	T:-40 to 120°C	GF	2013/2/18	2014/2/18	
V	ML-257	Multimeter	HP 34401A	Note 1	Agilent	2013/3/8	2014/3/8	
V	ML-494	Electronic Balance	XS1220M-SCS	1-1000 gf	CHUANHUA	2013/8/15	2014/8/15	
	T.3 Vibration							
V	ML-233	Vibration	KD-9636-EM-300F2K-30N80	F:5~2000Hz G:0.2~20G	King Design	2013/9/27	2014/9/27	
V	ML-257	Multimeter	HP 34401A	Note 1	Agilent	2013/3/8	2014/3/8	
V	ML-494	Electronic Balance	XS1220M-SCS	1-1000 gf	CHUANHUA	2013/8/15	2014/8/15	
V	ML-552	Data Logger	313	15~35 °C; 30~80 %RH	CENTER	2013/10/16	2014/10/16	
	T.4 Shock							
V	ML-056	Shock	DP-1200-25	G:10~600G	King Design	2013/9/27	2014/9/27	
V	ML-257	Multimeter	HP 34401A	Note 1	Agilent	2013/3/8	2014/3/8	
V	ML-494	Electronic Balance	XS1220M-SCS	1-1000 gf	CHUANHUA	2013/8/15	2014/8/15	
V	ML-551	Data Logger	313	15~35 °C; 30~80 %RH	CENTER	2013/10/16	2014/10/16	
	T.5 External Short Circuit							
V	ML-534	mΩ Hitester	3540	1mΩ ~ 30kΩ	YEOW LONG	2013/10/18	2014/10/18	
V	ML-339	Data Acquisition	MX100-E-1D	1-100 Vdc, -50 to 150°C	Yokogawa	2013/6/5	2014/6/5	
V	ML-521	Chamber	WIT IPC-1000(3F)	-20 to 150 °C	WIT	2013/10/14	2014/10/14	
	T.6 Impact (Component cell)							
V	ML-340	Data Acquisition	MX100-E-1D	1-100 Vdc, -50 to 150°C	Yokogawa	2013/3/21	2014/3/21	
V	ML-076	Impact Tester			JYI SHENG	2013/1/15	2014/1/15	
	T.7 Overcharge							
V	ML-481	Power Supply	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2013/6/5	2014/6/5	
V	ML-482	Power Supply	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2013/6/5	2014/6/5	
V	ML-483	Power Supply	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2013/6/5	2014/6/5	
V	ML-484	Power Supply	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2013/6/5	2014/6/5	
V	ML-485	Power Supply	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2013/6/5	2014/6/5	
V	ML-486	Power Supply	DS10014	1-100Vdc, 0.3-14.4A	MOTECH	2013/6/5	2014/6/5	
V	ML-487	Power Supply	DS6024	1-60 Vdc, 0.3-24A	MOTECH	2013/6/5	2014/6/5	
V	ML-488	Power Supply	DS6024	1-60 Vdc, 0.3-24A	MOTECH	2013/6/5	2014/6/5	
V	ML-489	Power Supply	DS6024	1-60 Vdc, 0.3-24A	MOTECH	2013/6/5	2014/6/5	
V	ML-490	Power Supply	DS6024	1-60 Vdc, 0.3-24A	MOTECH	2013/6/5	2014/6/5	
V	ML-549	Data Logger	313	15~35 °C; 30~80 %RH	CENTER	2013/10/16	2014/10/16	
Note 1: DC Voltage: 0.1-1000V; AC Voltage: 0.5-700V at 60Hz, 1kHz; Resistance: 10Ω-10MΩ; DC Current: 0.1mA-3A; AC Current: 0.01-3A at 60Hz, 0.01-1A, at 1kHz.								

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Control Number : SLEU-1311003

T.4 Shock

Start time: 11 / 06 / 15 : 36
Finish time: 11 / 07 / 10 : 34

Ambient temp.: 24.4 °C

Operator: Stephy

Reviewer: Esmond

Sample No.: 01						Sample No.: 05					
	Before	After	Variation		Results		Before	After	Variation		Results
Mass (g)	283.5	283.5	Mass loss %	0.00%	P	Mass (g)	283.5	283.5	Mass loss %	0.00%	P
OCV (V)	8.26	8.26	Remained OCV%	100.00%		OCV (V)	8.21	8.21	Remained OCV%	100.00%	
Sample No.: 02						Sample No.: 06					
	Before	After	Variation		Results		Before	After	Variation		Results
Mass (g)	283.6	283.6	Mass loss %	0.00%	P	Mass (g)	283.7	283.7	Mass loss %	0.00%	P
OCV (V)	8.27	8.27	Remained OCV%	100.00%		OCV (V)	8.23	8.23	Remained OCV%	100.00%	
Sample No.: 03						Sample No.: 07					
	Before	After	Variation		Results		Before	After	Variation		Results
Mass (g)	283.6	283.6	Mass loss %	0.00%	P	Mass (g)	283.5	283.5	Mass loss %	0.00%	P
OCV (V)	8.25	8.25	Remained OCV%	100.00%		OCV (V)	8.26	8.26	Remained OCV%	100.00%	
Sample No.: 04						Sample No.: 08					
	Before	After	Variation		Results		Before	After	Variation		Results
Mass (g)	283.6	283.6	Mass loss %	0.00%	P	Mass (g)	283.6	283.6	Mass loss %	0.00%	P
OCV (V)	8.25	8.25	Remained OCV%	100.00%		OCV (V)	8.26	8.26	Remained OCV%	100.00%	

T.5 External Short Circuit

Start time: 11 / 07 / 11 : 13
Finish time: 11 / 14 / 11 : 25

Ambient temp.: 23.6 °C

Operator: Stephy

Reviewer: Esmond

	Sample No.: 01		Sample No.: 02		Sample No.: 03		Sample No.: 04		Sample No.: 05		Sample No.: 06		Sample No.: 07		Sample No.: 08	
Resistance (<100mΩ)	54.6		56.4		55.9		58.1		52.3		57.6		57.1		52.4	
OCV before test/ after short circuit(V)	8.26	0.00	8.27	0.00	8.25	0.00	8.25	0.01	8.21	0.00	8.23	0.00	8.26	0.00	8.26	0.00
Max Temp. (< 170°C)	55.8		55.5		55.6		55.4		55.6		55.1		55.2		55.4	
Results	P		P		P		P		P		P		P		P	

T.6 Impact (Component cell)

Start time: 10 / 28 / 10 : 14
Finish time: 10 / 29 / 10 : 41

Ambient temp.: 23.7 °C

Operator: Stephy

Reviewer: Esmond

	Sample No.: 01C	Sample No.: 02C	Sample No.: 03C	Sample No.: 04C	Sample No.: 05C
OCV before test(V)	3.68	3.68	3.68	3.69	3.68
Max Temp. (< 170°C)	94.5	92.0	90.7	93.3	95.1
Results	P	P	P	P	P
	Sample No.: 06C	Sample No.: 07C	Sample No.: 08C	Sample No.: 09C	Sample No.: 10C
OCV before test(V)	3.68	3.68	3.68	3.69	3.67
Max Temp. (< 170°C)	91.7	92.7	94.6	91.4	97.3
Results	P	P	P	P	P

T.7 Overcharge

Start time: 10 / 30 / 11 : 16
Finish time: 11 / 15 / 16 : 32

Ambient temp.: 23.9 °C

Operator: Stephy

Reviewer: Esmond

	Sample No.: 09	Sample No.: 10	Sample No.: 11	Sample No.: 12	Sample No.: 13	Sample No.: 14	Sample No.: 15	Sample No.: 16
OCV before test(V)	8.36	8.37	8.36	8.35	8.35	8.36	8.36	8.36
Results	P	P	P	P	P	P	P	P

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7. Equipment for Test:

